

The Advanced Photon Source XAFS School July 6 - 10, 2009

A broad introduction to the collection and analysis of XAFS data.

Conference Location:

Argonne National Laboratory
Advanced Photon Source
Argonne, IL 60439

Lectures:

B401/E1100-1200

APS Beamlines:

5-BM-D, 9-BM, 10-BM, 12-BM, and 20-BM

Beamline Instructors:

Mali Balasubramanian,
ANL, APS Sector 20 BM
Trudy Bolin,
ANL, APS Sector 9 BM
Nadia Leyarovska,
ANL, APS Sector 12
Qing Ma,

Northwestern University, APS Sector 5
Carlo Segre

IL Institute of Technology, APS Sector 10

Lectures:

Scott Calvin,
Sarah Lawrence College
Serena DeBeer George,
Stanford University, SSRL
Shelly Kelly,
UOP

Matt Newville, University of Chicago, APS Sector 13 Bruce Ravel, NIST

Program Committee:

Scott Calvin, Sarah Lawrence College Julie Cross, APS Shelly Kelly, UOP Matt Newville, University of Chicago Bruce Ravel, NIST

Local Organizing Committee:

Julie Cross, jox@aps.anl.gov Rachael Reed, rreed@aps.anl.gov

Purpose:

The five-day course includes classroom lectures delivered by leading experts in the field, and handson instruction in sample preparation, data collection, and data analysis using state-of-the-art software. The lectures will cover the basic physics of x-ray absorption and XAFS theory, as well as best practices in XAFS sample preparation, data collection, and basic principles of data analysis. Participants will collect XAFS data from a variety of samples during the beamline practicals, then learn to analyze the data collected during the data analysis laboratories. Two days are devoted to hands-on experiments at APS spectroscopy beamlines 5 BM, 9 BM, 10 BM, 12 BM, and 20 BM. Significant time is spent on hands-on instruction in data processing and data analysis using Feff, Ifeffit and Athena & Artemis.

Possible activities and lecture topics:

- Overview of XAFS Theory
- Collecting Fantastic XAFS Data
- Athena Basics
- XAFS Analysis
- Tour of XAFS Beamlines and Sample Prep Facilities
- Related and Complimentary Techniques
- Getting Beamtime at the APS
- XAFS Analysis Examples and Demonstrations
- Detectors and Optics
- Interpretation of XANES
- Advanced XAFS Analysis
- Data Analysis Labs

Important Dates:

5/11/09 Last day to apply/register for the course

5/18/09 Acceptance letters sent by email

6/19/09 Tuition due

07/06/09 9:00 am, School begins 07/10/09 12:00 pm, School ends

Web Page:

http://xafs.org/Workshops/APS2009